## Notice of References Cited

Applicant(s)/Patent Under Reexamination Application/Control No. 10/751,943 SAMUELSON ET AL. Art Unit Examiner Page 1 of 1 2891 Matthew W. Such

## U.S. PATENT DOCUMENTS

				U.S. PATENT DOGGINENTO	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*		US-2002/0040884	04-2002	Hantschel et al.	216/2
	A		11-2003	Lu et al.	117/104
*	В	US-2003/0213428			438/378
*	С	US-6,913,982	07-2005	Lim et al.	73/105
*	D	US-2002/0178799	12-2002	Kitazawa et al.	250/306
*	E	US-6,011,261	01-2000	Ikeda et al.	250/300
	F	US-			
<del>  -</del>	G	US-			
<u> </u>	Н	US			_
	1	US-			
	J	US-			1 1
	К	US-			
	L	US-			
	М	US-			
		1		FOREIGN PATENT DOCUMENTS	

## FOREIGN PATENT DOCUMENTS

	FOREIGN FATERY SOCIAL					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
		oculary doctor				
	N		<u> </u>			
	0					
	Р					
一	a					
	<u> </u>					
l _	R	l	<del> </del>			
	s					
<u> </u>	-		1			
		<u> </u>		NON PATENT DOC	NIMENTS	

## NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Snow, Campbell and Novak. Applied Physics Letters. 80 (2002): 2002-2004.				
	v	Dai and Franklin. Applied Physics Letters. 73 (1998): 1508-1510.				
	w	Rao, Eklund, Bandow, Thess and Smalley. Nature. 388 (1997): 257-259.				
	x	Lee, Kim, Fischer, Thess and Smalley. Nature. 388 (1997) 255-257.				
1		SEC. 1500 MDER 5 707 (500 MDER				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.